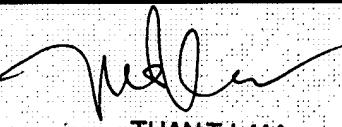


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/672,437	NALBANT, MEHMET K.
	Examiner Hiep Nguyen	Art Unit 2816

ISSUE CLASSIFICATION			
ORIGINAL		CROSS REFERENCE(S)	
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)
327	538	327	104 172 110
INTERNATIONAL CLASSIFICATION		363	21.1 21.11 21.18
G	0 5	F	1/10
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Hiep Nguyen 11-03-06
(Assistant Examiner) (Date)

Hiep Nguyen / 11/03/06
(Legal Instruments Examiner) (Date)



TUAN T. LAM
PRIMARY EXAMINER
(Primary Examiner) (Date)
11/19/06

Total Claims Allowed: 24

O.G. Print Claim(s)	O.G. Print Fig.
1	2

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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